INSTRUMENTAL FACILITIES

The following Instrumental facilities are provided by the CIC, Madurai Kamaraj University

High-Resolution Transmission Electron Microscope (HR-TEM)

The FEI Tecnai G² 20 S-TWIN TEM is designed to offer an imaging and analysis solution for life sciences, sciences, nanotechnology, and semiconductor and data storage industries. A wide range of functionality and techniques is available and can be combined on the Tecnai G² 20 S-TWIN TEM, to name a few: high contrast imaging, HR-TEM and SAED, using embedded detectors and components like BF/DF, CCD and corrected optics.

Contact

Prof. S. Murugesan, School of Chemistry Dr. B. Ashok Kumar, Assoc. Prof. School of Biotechnology

2. **Scanning Electron Microscope with EDS Analyzer**

The TESCAN VEGA3 SBH is a versatile tungsten thermionic emission SEM system intended for both high- and low vacuum operations. VEGA3 is equipped with modern electron optics.

Manufacturer: TSCAN (Floor Model)

High tension: 30 kV

Electron source: W filament: Resolution: 2 nm

Detectors: SE and BSE

Magnification Range: up to 1,50,000X

EDS Manufacture: EDAX

Contact: Dr. P. Suresh, Asst. Prof, School of Chemistry

Dr. J. Annaraj, Asst. Prof. School of Chemistry



Essential specification:

High tension: 200 kV

Electron source: LaB₆ or W emitter TEM point resolution: 0.24 nm; Line resolution: 0.14 nm; Min focus step: 1.5 nm TEM magnification range: 25X-1030 kX

3. **Simultaneous Thermal Analyser:**

Thermo Gravimetric analyser with Differential **Scanning Colorimetry (TG-DSC)**

Manufacturer : Perkin-Elmer Temperature Range : 50 °C to 1300 °C : 2 °C/min. to 30 °C/min Heating Rate

Balance resolution : 0.2 µg

: Air, N₂, Argon Atmosphere Temperature accuracy: ±0.5 °C Calorimetric accuracy: ±5%

Samples must be non-toxic, non-corrosive, and non-

explosive

Contact: Dr. A. Siva, Asst. Prof., School of Chemistry





4. UV-vis. Spectrophotometer with Diffused Reflectance (DRS)

Make and model: Shimadzu 2550 with ISR 2200

Wavelength range: 200 to 800 nm

Band width: variable bandwidth (0.2 to 4 nm)

Contact

Dr. R. Ranjith Kumar. Asst. Prof., School of Chemistry Dr. A. Dhakshinamoorthy. Asst. Prof. School of Chem.

5. Spectrofluorometer

Manufacture: Horiba

Emission detection wavelength: 185-850 nm

Contact:

Dr. R. Ranjith Kumar. Asst. Prof., School of Chemistry Dr. A. Dhakshinamoorthy. Asst. Prof. School of Chem.

6. Solar Simulator & IPCE System

Solar simulator simulate 1 sun intensity AM 1.5 solar spectrum in the laboratory. The irradiance area is 50 cm X 50 cm. I-V measurement system coupled with this solar simulator measures the photo-voltage and photocurrent characteristics of the newly fabricated solar cells by LSV mode. IPCE system is useful to measure the incident photon to current efficiency of the solar cells.

Solar simulator make: Photo Emission Technology IPCE System make: Newport, Oriel QEPVSI-B

Contact:

Dr. G. Gnana Kumar, Asst. Prof., School of Chemistry Dr. M. Jeyanthinath, Asst. Prof. School of Chem.



Theoretical and simulations studies:

VASP/Gaussian/Schrodinger softwares installed In high performance computing servers / GPU servers.

*Note: This facility is available only to the researchers from Madurai Kamaraj University

